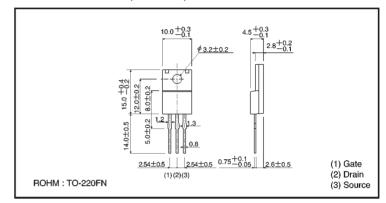
Switching (600V, 4A) 25K2792

Features

- 1) Low on-resistance.
- 2) Fast switching speed.
- 3) Wide SOA (safe operating area).
- 4) Gate-source voltage (Vgss) guaranteed to be ± 30 V.
- 5) Easily designed drive circuits.
- 6) Easy to parallel.

●Structure Silicon N-channel MOSFET

External dimensions (Units: mm)



● Absolute maximum ratings (Ta = 25°C)

Parameter		Symbol Limits		Unit
Drain-source voltage		Voss	600	V
Gate-source voltage		Vgss	±30	V
Drain current	Continuous	Ιο	4	Α
	Pulsed	IDP*	16	Α
Reverse drain current	Continuous	Idr	4	Α
	Pulsed	IDRP*	16	А
Total power dissipation (Tc=25°C)		P□	30	W
Channel temperature		Tch	150	Ç
Storage temperature		Tstg	−55~ +150	Ĉ

^{*} Pw \leq 10 μ s, Duty cycle \leq 1%

Packaging specifications

	Package	Bulk
Type	Code	_
	Basic ordering unit (pieces)	500
2SK2792		0



Transistors 2SK2792

●Electrical characteristics (Ta = 25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Gate-source leakage	Igss	_	_	±100	nA	V _{GS} =±30V, V _{DS} =0V
Drain-source breakdown voltage	V(BR) DSS	600	_	_	٧	ID=1mA, VGS=0V
Zero gate voltage drain current	Ipss	_	_	100	μΑ	V _{DS} =600V, V _{GS} =0V
Gate threshold voltage	VGS (th)	2.0	_	4.0	٧	V _{DS} =10V, I _D =1mA
Static drain-source on-state resistance	RDS (on)	_	1.8	2.4	Ω	In=2A, Vgs=10V
Forward transfer admittance	Y _{fs}	1.0	2.7	_	S	I _D =2A, V _{DS} =10V
Input capacitance	Ciss	_	610	_	pF	V _{DS} =10V
Output capacitance	Coss	_	120	_	pF	V _{GS} =0V
Reverse transfer capacitance	Crss	_	53	_	pF	f=1MHz
Turn-on delay time	td (on)	_	14	_	ns	I _D =2A, V _{DD} ≒150V
Rise time	tr	_	15	_	ns	V _{GS} =10V
Turn-off delay time	td (off)	_	48	_	ns	RL=75Ω
Fall time	tr	_	34	_	ns	R _G =10Ω
Reverse recovery time	trr	_	540	_	ns	IDR=4A, VGS=0V
Reverse recovery charge	Qrr	_	3.1	_	μC	di/dt=100A/ μs

Electrical characteristic curves

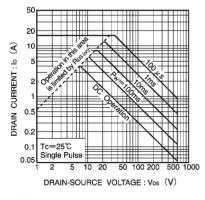


Fig.1 Maximum safe operating area

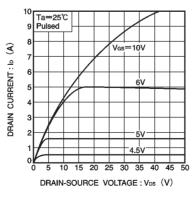


Fig.2 Typical output characteristics

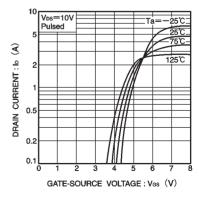


Fig.3 Typical transfer characteristics

Transistors 2SK2792

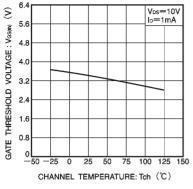


Fig.4 Gate threshold voltage vs. channel temperature

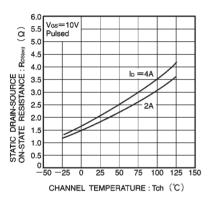


Fig.7 Static drain-source on-state resistance vs. channel temperature

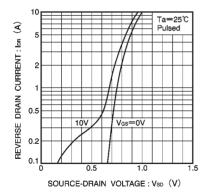


Fig.10 Reverse drain current vs. source-drain voltage (I)

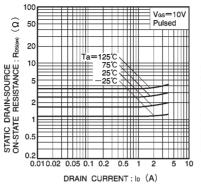


Fig.5 Static drain-source on-state resistance vs. drain current

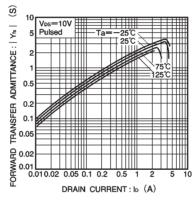


Fig.8 Forward transfer admittance vs. drain current

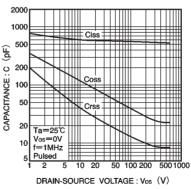


Fig.11 Typical capacitance vs. drain-source voltage

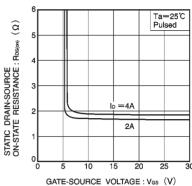


Fig.6 Static drain-source on-state resistance vs. gate-source voltage

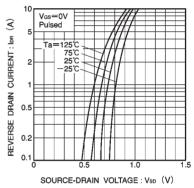


Fig.9 Reverse drain current vs. source-drain voltage (I)

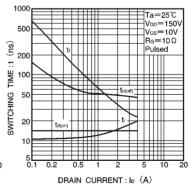
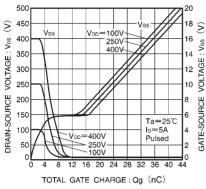


Fig.12 Switching characteristics (See Figures 16 and 17 for the measurement circuit and resultant waveforms)



Transistors 2SK2792



5000 Ta=25℃ di/dt=100A/ µ ns) V_{GS}=0V 2000 <u>ئے</u> Pulsed H 1000 RECOVERY 500 200 REVERSE

REVERSE DRAIN CURRENT: IDR (A)

Dynamic input characteristics Fig.13 (See Figure 18 for measurement circuit)

Fig.14 Reverse recovery time vs. reverse drain current

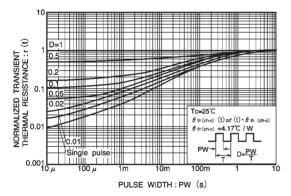


Fig. 15 Normalized transient thermal resistance vs. pulse width

Switching characteristics measurement circuit

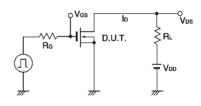


Fig.16 Switching time measurement circuit

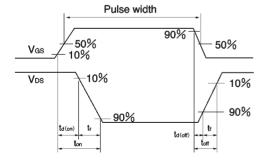


Fig.17 Switching time waveforms

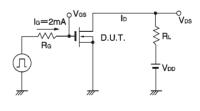


Fig.18 Gate charge measurement circuit

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